The Lector CRAPAR

BNL CRADA BNL-C-95-05



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Development of a 10-bit 500 Msample/sec Waveform Digitizer

Outline:

- Overview & History
- Objectives
- Technical Progress
- Future Potential

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Waveform Digitizer: Overview

"An Oscilloscope on a chip" A simple, robust, low-cost device to sample fast analog signals and convert them into digital data.

The device is characterized by the following:

• Sampling rate.

The number of digital samples per second.

• Dynamic range/effective bits.

The number of bits per sample.

• Input bandwidth.

The speed of the signal that can be captured.

Note that a mathematical theorem limits the bandwidth to less than half the sampling speed.

• Depth of Memory.

The length of time samples can be stored prior to readout

• Readout speed.

The length of time for the acquisition of digitized samples into standardized format.

• Cost.

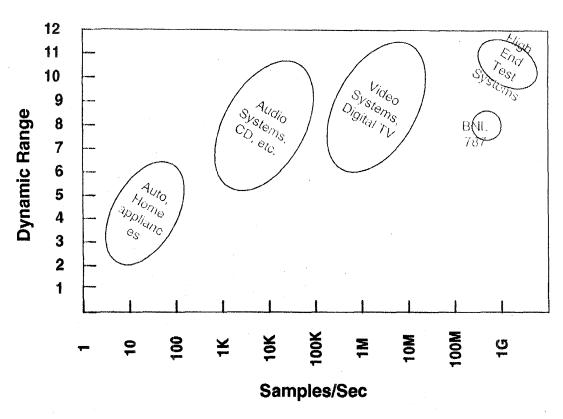


Figure 1 Performance of current Digital to Analog systems.

Funding

DOE (BNL)

	3/95-2/96		3/96-2/97	
	BNL CRADA	BNL non- CRADA	BNL CRARA	BNL non- CRADA
Manpower	237,022	0	248,873	0
Software	26,074	0	0	12,000
Parts	8,148	0	22,861	15,000
Total	271,244	0	271,734	27,000

Industry (LeCroy)

ADC design	207,000	
Memory design	253,000	·
System design	21,000	
Total	481,000	

Project Summary

- Approved in late 1994, funded in March 1995.
- Goal is to utilize existing LeCroy Front End developments and BNL previous efforts to:
 - Extend the dynamic range from 8 to 9-10 bits.
 - Extend the depth of memory.
 - Lower the cost.
 - Increase availability to general research and industrial community.

Subsystem	Responsibility
Analog Front End (S/H) IC	LeCroy
MFE415 & MSH417	·
ADC IC	LeCroy
MAD422	
Memory IC	LeCroy
MEM424	
Integration of front end and extension to 9-10 bits (MCM)	BNL (Stony Brook)
(BNL-LRS 1)	
Fast readout controller	BNL
(BNL-LRS 2)	
Bus interface logic	BNL
System Integration	BNI.

Why BNL, Stony Brook and LeCroy?

- Long standing interest in this area.
- Proven accomplishments.
- Matched an Non-overlapping skills.

Examples

- BNL-E787 produced one of the largest waveform digitizers in existence.
 - 500 Msamples/sec at 8 bits dynamic range.
 - 2-400 μsec memory.
 - Fast readout (50 Mb/sec).
 - Zero suppression at write time.
 - 500 Channels.
 - In operation since 1988.
- LeCroy is one of the largest producers of high performance test systems.
 - Gsample/sec digital oscilloscopes.
 - Innovative Front End IC design.

Benefits and relevance to DOE mission

- Advances in this area of instrumentation are of critical importance to many areas of applied and basic research.
 - Detector instrumentation (the majority of US high energy physics research is funded by DOE).
 - Accelerator instrumentation (All US accelerators are funded entirely by DOE).
 - Test systems (relevant to DOE's mission in energy, environmental and health areas).
- Existing laboratory expertise and developments are made available to US industry.
 - First generation of devices developed for specific research purposes with DOE's support in 1988.
 - Leveraging of existing infrastructure allows for an efficient transfer to industry.

There is strong interest from both research and industrial community in this development.

Partial List of Expressed Interest (Customers?).

- High Energy/Nuclear Physics
 - g-2 Experiment at BNL.
 - Rare Kaon Experiments at BNL.
 - RHIC Beam Instrumentation Group.
- Industry (ref. LeCroy)

At least one previous generation of E787 development has been licensed to outside industry (SandersAssoc, Lockheed Corp.).

Technical Progress

- Sample & Hold, ADC, and Memory exist.
 - Sample & Hold capable of providing over 7 effective bits at 150 MHz input bandwidth (2GHz analog bandwidth).
 - ADC capable of 500 Msamples/sec and 8 bits of dynamic range.
 - Memory capable of 256 Kbytes and 2 nsec write speed.
- Integration MCM module has been designed and is under fabrication.
 - Use of a Multi-Chip Module (MCM) is essential to lower noise, increase packaging density and enhance reliability.
 - MCM is a single deliverable component that can be used by others.
- Readout custom IC designed and tested.
 - Fast readout with "on the fly" zero subtraction is essential to allow use of the device at high rates.
 - Standardized output formats allow use in a wide variety of modules.
 - Designed using VHDL to allow utilization of the latest technology without extensive redesign.
- Board level integration has started.

Specification of Waveform Digitizer

8 Channels in a single module capable of operating as 8 8-bits, 4 9-bits or 2 10-bits ADC.

Sampling Speed

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Depth of Memory

Input Bandwidth

Readout Speed

Zero suppression

Bus interface standard

Power

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Software Support

> 500 Msamples/sec

150-200 MHz

256 µsec

40 nsec per non-zero sample

At read, with pre and post sampling

CAMAC, Fastbus, VME

< 60 watt /module

Standard PC and UNIX readout codes

